Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/023,737	MASUI ET AL.	
Examiner	**Art Unit**	
Steven HD Nguyen	2665	

SEARCHED			
Class	Subclass	Date	Examiner

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner
See EastSearch		7/15/06	[signature]

SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR
See East search history	12/5/2005	ST
IEEE, busy tone, admission control	12/5/2005	ST
East search history	7/15/06	[signature]